

Application/Control No.	Applicant(s)/Patent under Reexamination	mination	
10/735,886	TAKAYAMA ET AL.		
Examiner	Art Unit		
Nitin Parekh	2811		

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SEARCHED					
Class	Subclass	Date	Examiner		
257	Updated 758, 761- 763, 753	6/12/2006	NP		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
US PGPUB (see text search history)		6/12/2006	NP		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East 2.0.3, USPTO, JPO, EPO, IBM Tech. Discl., Derwent	6/12/2006	NP.	
Text search		NP	